FDS6682

FAIRCHILD SEMICONDUCTOR

30V N-Channel PowerTrench^o MOSFET

General Description

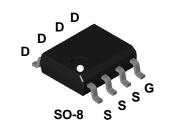
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{DS(ON)}$ in a small package.

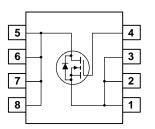
Applications

• DC/DC converter

Features

- 14 A, 30 V. $R_{DS(ON)}$ = 7.5 m Ω @ V_{GS} = 10 V $R_{DS(ON)}$ = 9.0 m Ω @ V_{GS} = 4.5 V
- Low gate charge (22 nC typical)
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





Absolute Maximum Ratings T_{A=25°C} unless otherwise noted

Symbol		Parameter		Ratings	Units	
V _{DSS}	Drain-Source	rce Voltage		30	V	
V _{GSS}	Gate-Sourc	rce Voltage		±20	V	
I _D	Drain Current – Continuous (M		(Note 1a)	14	А	
		- Pulsed		50		
P _D	Power Dissipation for Single Operation		n (Note 1a)	2.5	W	
			(Note 1b)	1.2		
			(Note 1c)	1.0		
T _J , T _{STG}	Operating a	nd Storage Junction Temp	erature Range	-55 to +150	°C	
	I Charac				°C/W	
$R_{ ext{ hetaJA}}$	Thermal Resistance, Junction-to-Ambient (Note 1a)		ient (Note 1a)	50		
$R_{ ext{ ext{ ext{ ext{ ext{ ext{ ext{ ext$	Thermal Resistance, Junction-to-Case (Note 1)		e (Note 1)	25	°C/W	
		g and Ordering I				
	Marking	Device	Reel Size	Tape width	Quantity	
Device	•			12mm	2500 units	

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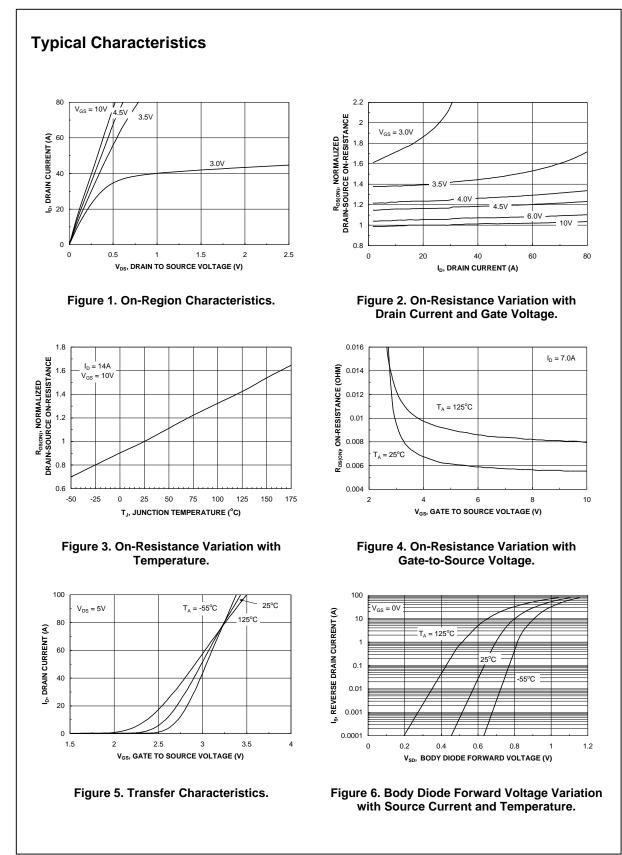
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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			•		
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, \qquad V_{\text{GS}} = 0 \text{ V}$			10	μA
IGSSF	Gate–Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
IGSSR	Gate–Body Leakage, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)			•		•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, \qquad I_D = 250 \ \mu A$	1	1.7	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		-5.6		mV/°0
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = 10 \; V, & I_D = 14 \; A \\ V_{GS} = 4.5 \; V, & I_D = 12.5 \; A \\ V_{GS} = 4.5 \; V, \; I_D = 12.5 \; A, \; T_J \!=\! 125^\circ \! C \\ \end{array} $		5.7 6.6 8	7.5 9 11.5	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	50			Α
g fs	Forward Transconductance	$V_{DS} = 10 V$, $I_D = 14 A$		70		S
Dynamic	Characteristics					
	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$		2310		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		582		pF
	Reverse Transfer Capacitance			237		pF
	· ·		l			F.
	IG Characteristics (Note 2) Turn–On Delay Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$		10	20	
t _{d(on)}	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		10 7	20 14	ns
t _r		-		44	70	ns
t _{d(off)}	Turn–Off Delay Time Turn–Off Fall Time	_		16	29	ns ns
t _f		V _{DS} = 15 V, I _D = 14 A,		22	31	-
Qg Qgs	Total Gate Charge Gate–Source Charge	$V_{GS} = 5 V$		6.4	31	nC nC
	Gate-Drain Charge	-		0.4 8		nC
	3			0		
Drain-So	ource Diode Characteristics				2.1	А
	Drain–Source Diode Forward					
V _{SD}	Voltage	$V_{GS} = 0 V$, $I_S = 2.1 A$ (Note 2)		0.7	1.2	V
otes: R _{eJA} is the sun		mal resistance where the case thermal reference is				

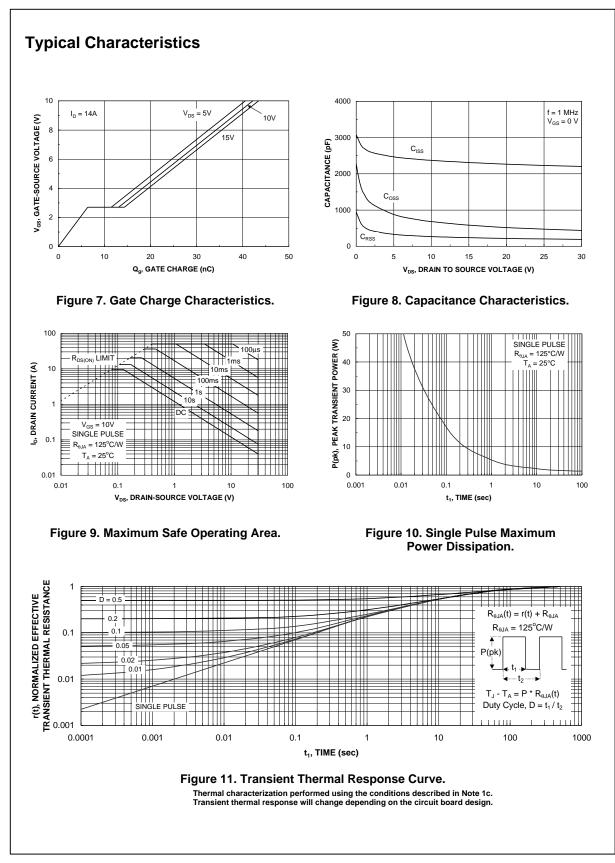
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Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty Cycle < 2.0%



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FDS6682 Rev D(W)

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